Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/701,548	KAGAWA ET AL.
Examiner	Art Unit

Yonel Beaulieu

Art Unit 3661

SEARCHED						
Class	Subclass	Date	Examiner			
701	93	6/4/2005	YB			
	96					
	23					
	70					
123	349	6/6/2005	YB			
180	170	6/6/2005	YB			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR		<u>') </u>
	DATE	EXMR
WEST	6/6/2005	YB
Inventor's Name Search	6/6/2005	YB .
Consulted w/SPE as to =	6/6/2005	ΥВ